

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

ABE ET AL.

Examiner

/Laura S. Weiner/

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-			
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**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 2004-093367	02-2004	Japan	Abe et al.	
O				abstract and translation	
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**NON-PATENT DOCUMENTS**

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